

# Specifications of Analog Silicon Microphone

# **GTM2718AT421WNC2**

Rev 1.0

(RoHS Compliant & Halogen Free)

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#### 1. PRODUCT DESCRIPTION

GTM2718AT421WNC2 is a miniature, good-performance, low power consumption, silicon microphone with analog output and top-port for sound input. It is a cost-effective alternative to traditional electret condenser microphone (ECM). Provided on tap-and-reel, it is ideally suited for high volume applications. And it can be attached directly to customer's PCB using standard automatic pick-and-place equipment and surface mounted via standard solder reflow equipment.

#### 2. APPLICATIONS:

- 1). Speech communication in TWS earphone
- 2). Smart electronic devices
- 3). Portable communication device
- 4). Notebooks, tablets, and desktops
- 5). Headphone and headset accessories
- 6). Digital video cameras

#### 3. FEATURES

> 2.75×1.85×0.95mm Top-port Package

Sensitivity of  $-42(\pm 1)$  dBV/Pa

 $\triangleright$  SNR of 58dB(A)

Omni-directional

➤ Flat Frequency Response

> High Reliability

➤ Good RF Immunity

➤ Lead-free Reflow Process Compatible

Ultra-stable Performance

Low Power Consumption

#### 4. ABSOLUTE MAXIMUM RATINGS

Supply Voltage: VDD to GND .....- $0.3V \sim 5V$ 

**ESD** Tolerance

The Lid Mode ......8kV

The I/O Pin Mode ......4kV

TEMPERATURE CHARACTERISTICS					
Parameter	Conditions	Min	Тур	Max	Unit
Operating Temperature		-40		+85	°C
Store on Town eveture	Solder on PC board	-40		+105	°C
Storage Temperature	In Tape and Reel	-10		+50	°C

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.



#### 5. ACOUSTIC & ELECTRICAL SPECIFICATIONS

**Test Conditions:** 

Ta = 25°C, R.H. = 50 $\pm$ 20%,  $V_{DD} = 2.0$ V, Input sound pressure  $P_{IN} = 94$ dB SPL@1kHz

SNR & noise floor measurement is based on  $100\text{Hz} \sim 10\text{KHz}$  passband with A-Weighting filter applied unless specifically specified in the table below.

Parameter	Conditions	Min	Тур	Max	Unit
Directivity			Omni-I	Directiona	ıl
Power Supply Voltage		1.6	-	3.6	V
Sensitivity	@1KHz (0 dB = 1V/Pa)	-43	-42	-41	dBV/Pa
Signal-to-Noise Ratio (SNR)	@1KHz (0 dB = 1V/Pa)	-	58	-	dB(A)
Total Harmonic Distortion (THD)	@100dB SPL @1KHz	-	0.2	-	%
Acoustic Overload Point (AOP)	@1KHz, THD < 10%	-	127	-	dB SPL
Power Supply Rejection (PSR)	217Hz, 100mVpp square wave	-	-96	-	dB
Sensitivity Loss Across Power Supply Voltage	Change in sensitivity from 1.6V to 3.6V power supply voltage	]	No change	e	dB
Total Operation Current	1.6V~3.6V power supply voltage	-	-	160	uA
Output Impedance	@1KHz (0dB=1V/Pa)	-	200	-	Ω



### 6. FREQUENCY RESPONSE CURVE

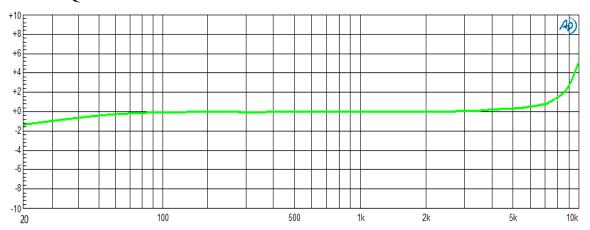
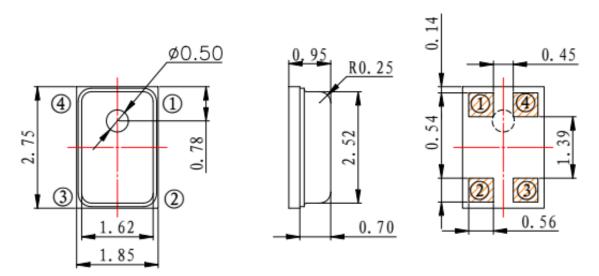


Figure 1. Typical free field frequency response (Normalized to 1 KHz)

#### 7. MECHANICAL SPECIFICATIONS



ITEM	DIMENSION	TOLERANCE	UNITS
LENGTH(L)	2.75	±0.10	mm
WIDTH(W)	1.85	±0.10	mm
HEIGHT(H)	0.95	±0.10	mm
ACOUSTIC PORT(AP)	Ф0.50	±0.10	mm

PIN OUTPUT		
PIN# FUNCTION		
1	VDD	
2	GND	
3	GND	
4	OUTPUT	

Note: Dimensions are in millimeters unless otherwise specified. Tolerance  $\pm 0.15$ mm unless otherwise specified

Figure 2. Detailed mechanical drawings

#### 8. RECOMMENDED CUSTOMER LANDING PATTERN

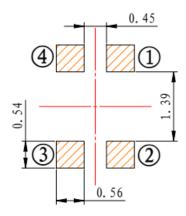


Figure 3. Recommended landing pattern on customers' PCB

#### 9. EXAMPLE SOLDER STENCIL PATTERN

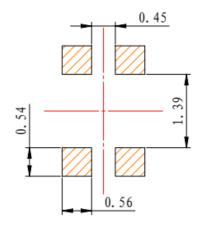


Figure 4. Example solder stencil pattern

#### 10.RECOMMENDED INTERFACE CIRCUIT

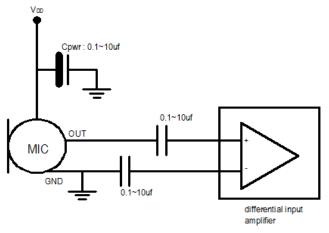


Figure 5. Recommended interface circuit for customers' applications

#### 11.PACKAGING SPECIFICATIONS

\*4. 00 ± 0. 10

\*2. 00 ± 0. 05

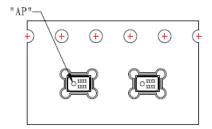
Ø1.50+0.1

\*0. 30 ± 0. 10

\*3. 10 ± 0. 10

\*3. 10 ± 0. 10

\*3. 10 ± 0. 10



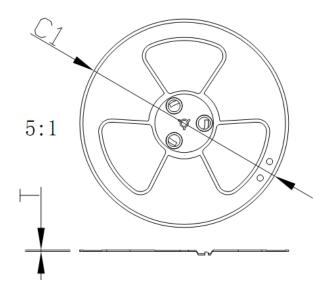
#### Notes:

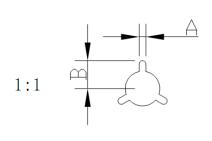
- (1) Dimensions are in millimeters unless otherwise specified;
- (2) Tape & Reel Per EIA-481 standard;
- (3) Label applied to external package and direct to reel;
- (4) Shelf life: Twelve (12) months when devices are to be stored in factory supplied, unopened ESD moisture sensitive bag under maximum environmental conditions of 30°C, 70% R.H.

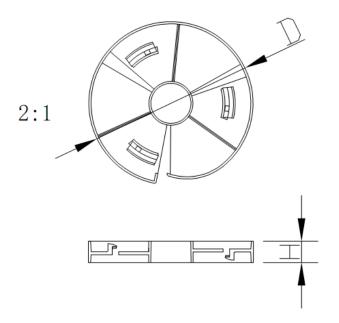
Order Part Number	Reel Diameter	Qty per Reel	
GTM2718AT421WNC2	13"	5,000	

Figure 6. Tape Specification









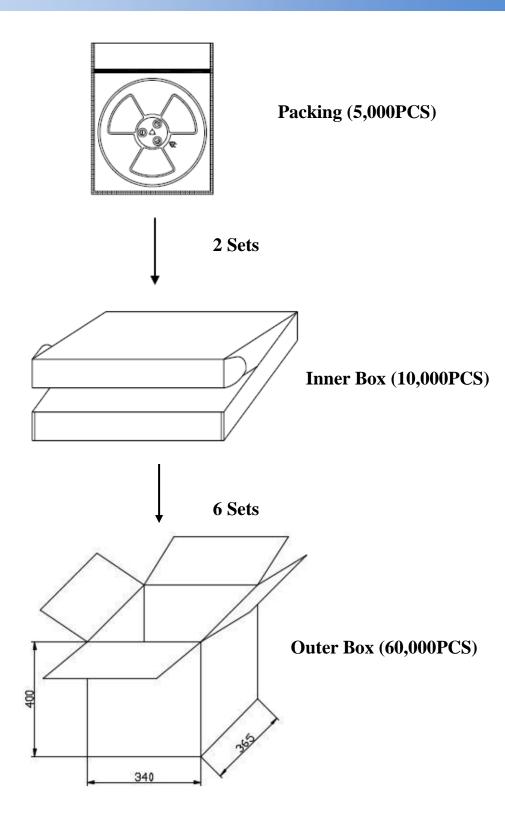
SPEC	13"
C1±1.0	Ф330
A±0.2	2.5
$B \pm 0.2$	10.5
T±0.2	2.0

Available Reel Size(mm)			
Tape Width	D±0.5	H+1	
12	Ф100	12.5	

5,000 Pieces of Products per Reel

Figure 7. Reel Specification



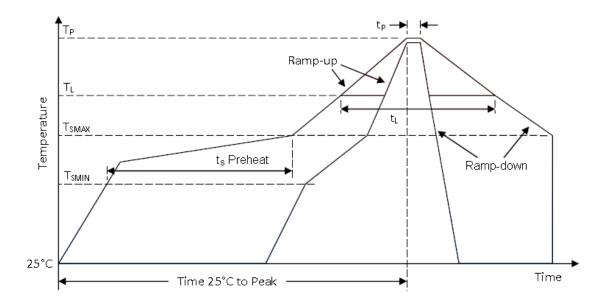


60,000 Pieces of Products per Carton

Figure 8. Packaging Specification



#### 12.SOLDER REFLOW PROFILE



Profile Feature	Pb-Free
Average Ramp-up Rate (T <sub>SMAX</sub> to T <sub>P</sub> )	3°C/second max.
$ \begin{array}{c} \text{Preheat} \\ \text{Temperature Min } (T_{SMIN}) \\ \text{Temperature Max } (T_{SMAX}) \\ \text{Time } (T_{SMIN} \text{ to } T_{SMAX})  (t_S) \\ \end{array} \\ \text{Time maintained above:} \\ \text{Temperature } (T_L) \\ \end{array} $	150°C 200°C 60-180 seconds 217°C
Time (t <sub>L</sub> )  Peak Temperature (T <sub>P</sub> )	60-150 seconds 260°C
Time within 5°C of actual Peak Temperature (t <sub>P</sub> )	20-40 seconds
Ramp-down Rate(T <sub>P</sub> to T <sub>SMAX</sub> )	6°C/second max
Time 25°C to Peak Temperature	8 minutes max

Figure 9. Recommended leadless solder reflow temperature profile

#### Notes:

- 1. Vacuuming over acoustical hole of the microphone is not allowed, because the device can be damaged by vacuum.
- Washing the board after reflow process is not allowed, because board washing and cleaning agents can damage the device. A device should not be exposed to ultrasonic processing or cleaning.
- 3. Recommended number of reflow is no more than 5 times.
- 4. Do not apply over 30 psi of air pressure into the port hole.
- 5. MSL (moisture sensitivity level) Class 1.



#### 13.RELIABILITY SPECIFICATIONS

Test item	Detail	Standard
Reflow Simulation	Refer to Sec.9 for solder reflow profile, total 5 times	/
Low Temperature Bias	Conditions: -40°C Duration:168 hours while under bias	IEC 60068-2-2 Test Aa
High Temperature Bias	Conditions: 105°C Duration:168 hours while under bias	IEC 60068-2-2 Test Ba
Thermal Shock	Conditions: 100 cycles of air-air thermal shock from -40°C to 125°C with 15-minute soaks	IEC 60068-2-4
Temperature/Humidity Bias	Conditions: 85°C/85%RH environment while under bias for 168 hours	JESD 22-A101A-B
Mechanical Shock	Conditions:3 pulses of 10,000g in the X,Y and Z direction	IEC 60068-2-27 Test Ea
Vibration Test	Test axis: X,Y,Z Conditions: 2~400Hz 1 oct/min Test time: 15 mins per axis Use fixture during the testing	IEC 60068-2-6
Drop Test	Conditions: For each sample, drop by all corners, edges, surfaces respectively. Steel floor. Drop height: 1800mm.	IEC 60068-2-32
ESD	Conditions: ±8KV direct contact to the lid when unit is grounded, ±4KV direct contact to the I/O pins.10 times	IEC 61000-4-2

#### Note:

Immediately after reliability test, the samples shall be stored under climatic conditions such as that normally exist in ordinary rooms or laboratories. Unless otherwise noted, the recovery period shall be 2 hours at least before performance testing. After test condition is performed, the sensitivity of the microphone shall not deviate more than 3dB from its initial value.



#### 14.REVISION HISTORY:

Version	Date	Description
1.0	4/26/2021	Initial Release

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